



The 19th IEEE Pacific Rim International Symposium on Dependable Computing (PRDC'13)

Vancouver, British Columbia, Canada
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<http://prdc.dependability.org/2013>

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Call for Papers

PRDC 2013 is the nineteenth in this series of symposia started in 1989 that are devoted to dependable and fault-tolerant computing. PRDC is recognized as the main event in the Pacific area that covers the many dimensions of dependability and fault tolerance, encompassing fundamental theoretical approaches, practical experimental projects, and commercial components and systems. As applications of computing systems have permeated into all aspects of daily life, the dependability of computing systems has become increasingly critical. This symposium provides a forum for countries around the Pacific Rim and other areas of the world to exchange ideas for improving the dependability of computing systems.

Topics of interest for submissions include (but are not limited to):

- Software and hardware reliability, testing, verification, and validation
- Dependability measurement, modeling, evaluation, and tools
- Self-healing, self-protecting, and fault-tolerant systems
- Software aging and rejuvenation
- Safety-critical systems and software
- Architecture and system design for dependability
- Fault-tolerant algorithms and protocols
- Reliability in cloud computing, Internet, and web systems and applications
- Cloud and Internet Information security
- Dependability issues in computer networks and communications
- Dependability issues in distributed and parallel systems
- Dependability issues in real-time systems, database, and transaction processing systems
- Dependability issues in autonomic computing
- Dependability issues in aerospace and embedded systems

Paper Submissions

Manuscripts should be submitted in the following categories: Regular Papers and Practical Experience Reports. Regular Papers should describe original research (not submitted or published elsewhere) and be not more than 10 pages using IEEE format guidelines or 20 pages double-spaced. Practical Experience Reports (max 6 pages using IEEE format guidelines or 12 pages double-spaced) should describe an experience or a case study, such as the design and deployment of a system or actual failure and recovery field data. The title page should include a 150-word abstract, five keywords, authors' names and affiliations, and a line specifying whether the submission is a Regular Paper or a Practical Experience Report. The full mailing address, phone, fax, and email address of the corresponding author should be specified. All submissions must be made electronically (in PDF format) on the web site. Please visit our web site for full submission instructions and updated information on the symposium. Papers will be reviewed internationally and selected based on their originality, significance, relevance, and clarity of presentation.

All accepted papers will be published by IEEE Computer Society Press. One outstanding paper will be selected to receive the Best Paper Award.

Important Dates

Submission: May 17, 2013 May 31, 2013

Notification: July 5, 2013 July 19, 2013



Call for Fast Abstracts

Fast Abstracts are lightly-reviewed 2-page manuscripts in IEEE format describing unpublished, in-progress, novel work, opinions or ideas. **The submission deadline is July 15, 2013.**

Call for Industry Track Submissions

The industry track provides a forum for researchers and practitioners to present and debate R&D challenges, practical solutions, case studies, and share field reliability data. Industry track submissions should be a maximum of 6 pages using IEEE format guidelines. **The submission deadline is July 15, 2013.**

Call for Posters

The poster session provides a forum to present and discuss works-in-progress with topics related to dependable systems. A poster paper should use the same format as a regular paper but with a maximum of 2 pages. **The submission deadline is July 15, 2013.**